Search Notes



Application/Control	No.

Reexamination 10576373 FUJITA ET AL.

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Applicant(s)/Patent Under

PATRICK D LYNCH

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SEARCHED

Class	Subclass	Date	Examiner
297	217.2, 217.3, 284.11, 452.49, 452.55, 452.56, 452.58,	01/09/2008	PL
	452.59		i

SEARCH NOTES

Search Notes	Date	Examiner
Inventor Search (eDAN)	01/09/2008	PL
Consulted Joe Edell on Search in 297	01/09/2008	PL
Searched Class 297 (EAST)	01/09/2008	PL
EAST Text Search	01/09/2008	PL
Forward/Backward Citation Search	01/09/2008	PL
Updated Search	09/24/2008	PL

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
297	217.2, 217.3, 284.11, 452.49, 452.55, 452.56, 452.58, 452.59	09/24/2008	PL
	PGPUBS Text Search of Claim Language	09/24/2008	PL

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